

CUSTOMER 客户:

# 产品规格书 SPECIFICATION

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PRODUCT 产品:_	SAW FILTER			
MODEL NO 型 号:_	KH-SAWF244A (可兼容 Band7/40)			
MARKING 印字:_	● B176			
PREPARED 编 制:_	CHECKED 审 核:			
APPROVED 批 准:	DATE 日期: 2017-08-04			
客户确认 CUSTOMER RECEIVED:				
审核 CHECKEI	批准 APPROVED	日期 DATE		

# 深圳市金航标电子有限公司 SHENZHEN KINGHELM ELECTRON CO., LTD.



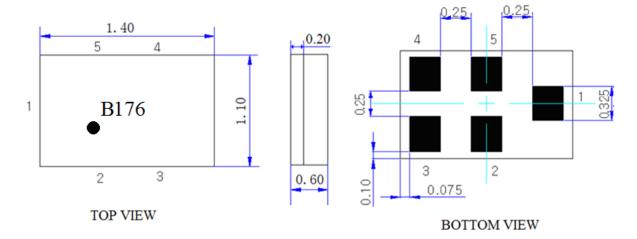
# 更改历史记录 History Record

更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark
2016-9-14	SP01	KH- SAWF244A		New specification.	
2017-08-04	SP02	KH- SAWF244A		Add dot marking.	

### 1. Application

- Low-loss RF filter for Bluetooth/WLAN with LTE Band 7/40 coexistence
- Impedance 50 ohm input and output.
- Unbalanced to unbalanced operation.
- Useable passband 78MHz.
- RoHS compatible.

#### 2. DIMENSION



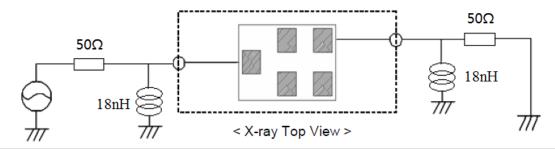
Pin configuration

- 1. Input (recommended) or Output
- 4. Output (recommended) or Input
- 2,3,5 To be grounded

### 3. Maximum Rating

Items	Conditions
Operation temperature rang	-30°C ~+85°C
Storage temperature rang	-40°C ~+85°C
ESD voltage	ESD(MM): 50VDC
Sensitive discharge device	ESD(HBM): 175VDC
DC Voltage VDC	5V (25+/-2 deg.C)
Max Input Power	24dBm 2000h

#### 4. TEST CIRCUIT

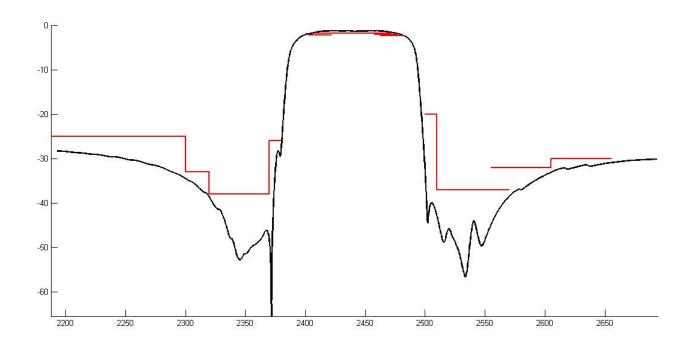




### 4. ELECTRICAL SPECIFICATION

Items	Test Condition	Min	Тур	Max	Unit	
Center Frequency	Fc	-	2442	-	MHz	
Insertion loss	2402.5~2421.5 MHz	-	1.8	2.2	dB	CH1
	2407.5~2426.5 MHz	-	1.5	1.8	dB	CH2
	2412.5~2471.5	-	1.5	1.8	dB	CH3~11
	2457.5~2476.5	-	1.8	2.0	dB	CH12
	2462.5~2481.5	-	2.0	2.3	dB	CH13
Amplitude Ripple (p-p)	2401~2483 MHz	-	1.2	2.0	dB	
VSWR	2401~2483 MHz	-	1.7	2.1	-	
	800~2300 MHz	25	30	-	dB	
	2300~2320 MHz	35	38	-	dB	
	2320~2370 MHz	40	43	-	dB	
	2370~2380 MHz	28	32	-	dB	
Attenuation (Reference level from 0dB)	2390 MHz	6	8	-	dB	
	2500~2510MHz	20	26	-	dB	
	2510~2570MHz	37	40	-	dB	
	2555~2605MHz	32	35	-	dB	
	2605~2655MHz	30	32	-	dB	
	2690~4000MHz	20	30	-	dB	
	4000~5000MHz	20	30	-	dB	
Input/Output Impedance	-	50Ω//18nH				

# 6. Typical frequency response





#### 7. ENVIRONMENTAL CHARACTERISTICS

#### 7.1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 5.

#### 7.2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 5.

#### 7.3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 5.

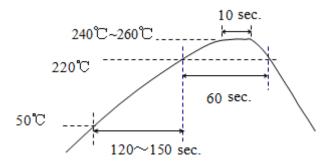
#### 7.4 Resistance to solder heat

- 1, immerge the solder bath at 260°C for 10 sec.
- 2, the iron at 370°C for 3 sec

#### 7.5 Solderability

Submerge the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the soldering pad must be covered with new solder. It shall meet the specifications in 5.

#### 7.6 Reflow soldering



The specimen shall be passed through the reflow furnace with the condition shown in the above profile for 1 time.

The specimen shall be stored at standard atmospheric conditions for 1h, after which the measurement shall be made. Test board shall be 1.6 mm thick. Base material shall be glass fabric base epoxy resin.

#### 7.7 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 5.

#### 7.8 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 5.

#### 8. REMARK

#### 8.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of

the component. Please avoid static voltage.

8.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

8.3 Soldering

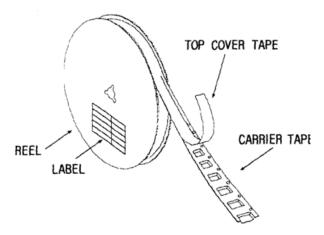
Only pad component may be solded. Please avoid soldering another part of component.

#### 9. Packing

- 9.1 Dimensions
  - (1) Carrier Tape: Figure 1
  - (2) Reel: Figure 2
  - (3) The product shall be packed properly not to be damaged during transportation and storage.
- 9.2 Reeling Quantity

3000 pcs/reel φ 178mm 10000 pcs/reel φ 259mm

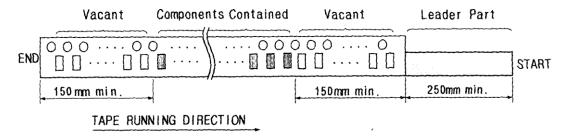
- 9.3 Taping Structure
  - (1) The tape shall be wound around the reel in the direction shown below.



#### (2) Label

Device Name	
Marking	
User Product Name	
Quantity	
Lot No.	

(3) Leader part and vacant position specifications.

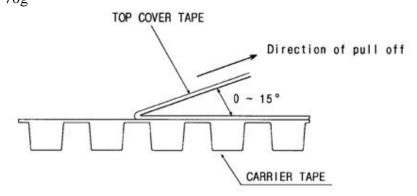




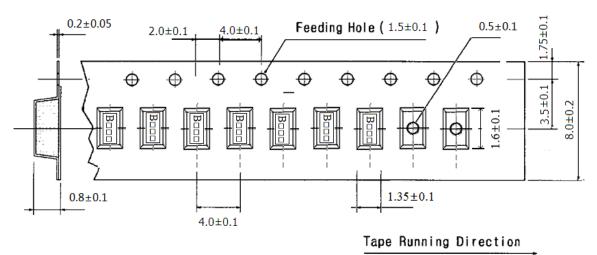
#### 10. TAPE SPECIFICATIONS

10.1 Tensile Strength of Carrier Tape: 4.4N/mm width 10.2 Top Cover Tape Adhesion (See the below figure)

(1) pull off angle: 0~15°
(2) speed: 300mm/min.
(3) force: 20~70g

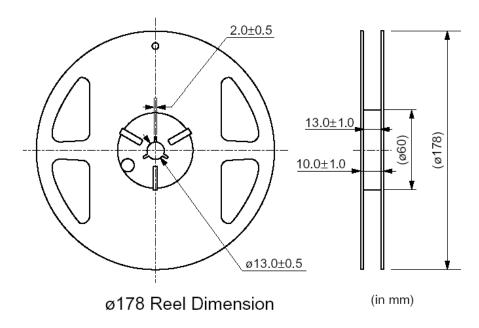


[Figure 1] Carrier Tape Dimensions

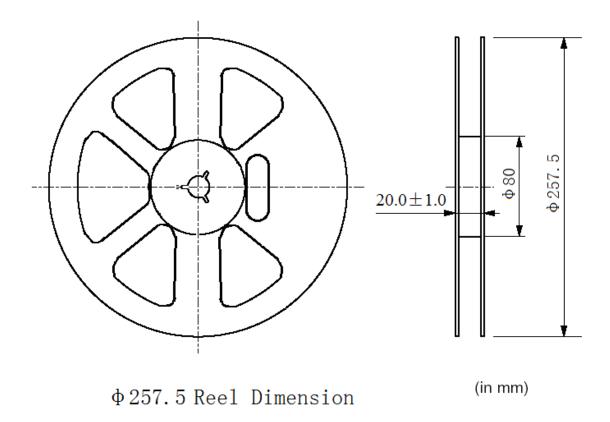




[Figure 2] 3000 pcs/reel φ 178mm



### 10000 pcs/reel φ 257.5mm



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